

Notice of References Cited	Application/Control No. 10/516,595		Applicant(s)/Patent Under Reexamination BAUDEN, JACQUES	
	Examiner Deborah Yee		Art Unit 1742	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,146,759	09-1992	Eguchi et al.	62/64
*	C	US-4,305,765	12-1981	Wilmotte et al.	134/15
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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